

# BUREAU OF ANALYSED SAMPLES LTD



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Certificate No Q 3993

## ANALYSIS REPORT

### COPPER BASE ALLOY REFERENCE MATERIAL

### CURM No. 54.05-4

### PHOSPHOR BRONZE

The material for this CURM was prepared specially for Bureau of Analysed Samples Ltd using a method of casting known to provide material of uniform composition in a form suitable for use as calibration reference materials in XRF and optical emission spectroscopic analysis. Using Optical Emission Spectrometry the samples have been shown, by statistically designed procedures, to produce reproducible results.

The chemical analysis of representative turnings was carried out independently by both Bureau of Analysed Samples Ltd., and another laboratory experienced in the analysis of non-ferrous materials. The values reported are the overall Means and Standard Deviations (s.d.) of three separate determinations made in each laboratory.

## ANALYSIS

mass content in %

Element	Mean	s.d.	Element	Mean	s.d.
Cu	<b>84.78</b>	0.04	Si	<b>0.006</b>	0.001
Sn	<b>11.36</b>	0.03	Mn	<b>0.078</b>	0.002
Pb	<b>1.14</b>	0.02	As	<b>0.063</b>	0.0002
Zn	<b>0.554</b>	0.004	Sb	<b>0.111</b>	0.0002
Ni	<b>1.28</b>	0.01	Al	<b>0.055</b>	0.002
P	<b>0.501</b>	0.011	S	<b>0.063</b>	0.003
Fe	<b>0.051</b>	0.001	Mg	<b>0.0021</b>	0.0001

Note: This CURM is available in bottles of 100 g of turnings or as a chill cast disc, approximately 50 mm diameter x 12 mm thick, with a single chilled working face (smaller diameter). Spectroscopic reproducibility has been shown to be reliable to a depth of 5 mm below the chilled surface as supplied. The disc should therefore be discarded when the thickness is reduced to 7 mm.

It has been established that materials of similar composition from different sources may respond differently on Optical Emission Spectrometers. CURMs are intended primarily for the construction of basic response curves which should be related to the response curves obtained from an identical examination of the user's own material.

N.B. Although these samples have been carefully analysed by both BAS Ltd and an independent laboratory, using the methods detailed overleaf, they have been classified as Reference Materials (RM)\* and not Certified Reference Materials (CRM)\* in order to distinguish them from the BAS Certified Reference Materials which are normally analysed by at least five laboratories.

\* See over for ISO definitions.

(PTO)

# CURM No. 54.05-4

## INFORMATION ON METHODS USED

Element	Chemical Methods used for the Analysis of this RM
Copper	Electrolytic deposition
Tin	Titration with iodine - nickel coil reduction.
Lead	FAAS
Zinc	FAAS
Nickel	FAAS
Phosphorus	Photometric as phosphovanadomolybdate
Iron	FAAS
Silicon	Photometric as molybdenum blue FAAS
Manganese	FAAS
Arsenic	Photometric with silver diethyldithiocarbamate, separation as arsine FAAS
Antimony	FAAS
Aluminium	FAAS
Sulphur	Gravimetric as barium sulphate. High frequency combustion - infrared absorption.
Magnesium	FAAS

Abbreviations: FAAS Flame Atomic Absorption Spectrometry

\* According to the International Organisation for Standardization (ISO Guide 30-1992) the definitions for RM and CRM are as follows:-

**Reference Material (RM):** A material or substance one or more of whose property values are sufficiently homogeneous and well established to be used for the calibration of an apparatus, the assessment of a measurement method, or for assigning values to materials.

**Certified Reference Material (CRM):** A reference material, accompanied by a Certificate, one or more of whose property values are certified by a procedure which establishes its traceability to an accurate realisation of the unit in which the property values are expressed and for which each certified value is accompanied by an uncertainty at a stated level of confidence.

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for **BUREAU OF ANALYSED SAMPLES LTD.**  
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**Revised September 2003**

*(first issued in September 1998 without reference to availability in chip as well as disc form)*